Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/002,595	SIRHAN ET AL.
Examiner	Art Unit
Hieu Phan	3738

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING SEARCH	STRATEGY	<u>') </u>
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